

1200V, 40A, Trench FS II Fast IGBT

General Description:

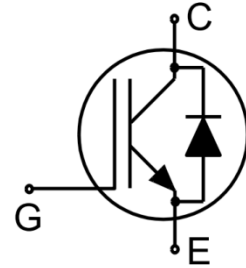
Using VCRR's proprietary trench design and advanced FS (Field Stop) second generation technology, the 1200V Trench FSII IGBT offers superior conduction and switching performances, and easy parallel operation;

Features

- Trench FSII Technology Offering
- Very low $V_{CE(sat)}$
- High speed switching
- Positive temperature coefficient in $V_{CE(sat)}$
- Very tight parameter distribution
- High ruggedness, temperature stable behavior

Application

- PV power
- Three-level Solar String Inverter
- UPS



Schematic diagram

Package Marking and Ordering Information

Device	Device Package	Device Marking
VCRR40TD120VT	TO-247	VCRR40TD120VT



Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate- Emitter Voltage	± 30	V
I_C	Collector Current	80	A
	Collector Current @ $T_C = 100^\circ\text{C}$	40	A
I_{Cpuls}	Pulsed Collector Current, t_p limited by T_{jmax}	160	A
-	turn off safe operating area, $V_{CE}=1200\text{V}$, $T_j=175^\circ\text{C}$	160	A
I_F	Diode Continuous Forward Current @ $T_C = 100^\circ\text{C}$	40	A
I_{FM}	Diode Maximum Forward Current	160	A
P_D	Power Dissipation @ $T_C = 25^\circ\text{C}$	468	W
	Power Dissipation @ $T_C = 100^\circ\text{C}$	234	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	260	$^\circ\text{C}$

Thermal Characteristic

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction to case for IGBT	0.32	$^{\circ}\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance, Junction to case for Diode	0.61	$^{\circ}\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	$^{\circ}\text{C}/\text{W}$

Electrical Characteristics ($T_c=25^{\circ}\text{C}$ unless otherwise noted)

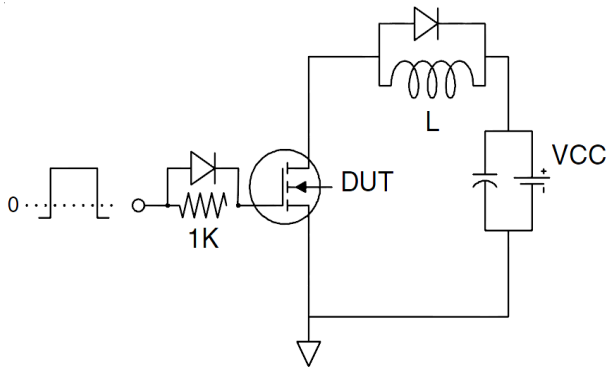
Symbol	Parameter	Conditions	Value			Units	
			Min.	Typ.	Max.		
Static Characteristics							
$V_{(BR)CES}$	Collector-Emitter Breakdown Voltage	$V_{GE}=0\text{V}, I_{CE}=1\text{mA}$	1200	--	--	V	
I_{CES}	Collector-Emitter Leakage Current	$V_{GE}=0\text{V}, V_{CE}=1200\text{V}$	--	--	200	μA	
$I_{GES(F)}$	Gate to Emitter Forward Leakage	$V_{GE}=+30\text{V}, V_{CE}=0\text{V}$	--	--	200	nA	
$I_{GES(R)}$	Gate to Emitter Reverse Leakage	$V_{GE}=-30\text{V}, V_{CE}=0\text{V}$	--	--	200	nA	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=40\text{A}$	$T_j=25^{\circ}\text{C}$	--	1.70	1.95	V
		$V_{GE}=15\text{V}$	$T_j=175^{\circ}\text{C}$	--	1.95	--	V
$V_{GE(th)}$	Gate Threshold Voltage	$I_C=1\text{mA}, V_{CE}=V_{GE}$	4.5	--	6.0	V	
Dynamic Characteristics							
C_{ies}	Input Capacitance	$V_{CE}=30\text{V}, V_{GE}=0\text{V}, f=1\text{MHz}$	--	5590	--	pF	
C_{oes}	Output Capacitance		--	177	--		
C_{res}	Reverse Transfer Capacitance		--	134	--		
Q_g	Total Gate Charge	$V_{CC}=960\text{V}, I_C=40\text{A}, V_{GE}=15\text{V}$	--	298	--	nC	
Q_{ge}	Gate to Emitter Charge		--	52	--		
Q_{gc}	Gate to Collector Charge		--	169	--		
Switching Characteristics							
$t_{d(ON)}$	Turn-on Delay Time	$V_{CE}=600\text{V}, I_C=40\text{A}, V_{GE}=0/15\text{V}, R_g=8\Omega$ Inductive Load	--	19	--	ns	
t_r	Rise Time		--	17	--		
$t_{d(OFF)}$	Turn-Off Delay Time		--	170	--		
t_f	Fall Time		--	18	--		
E_{on}	Turn-On Switching Loss		--	2.2	--	mJ	
E_{off}	Turn-Off Switching Loss		--	1.3	--		
E_{ts}	Total Switching Loss	--	3.5	--			
E_{on}	Turn-On Switching Loss	$V_{CE}=600\text{V}, I_C=40\text{A}, V_{GE}=0/15\text{V}, R_g=8\Omega$ $T_j=175^{\circ}\text{C}$	--	2.8	--	mJ	
E_{off}	Turn-Off Switching Loss		--	1.6	--		
E_{ts}	Total Switching Loss		--	4.4	--		

Electrical Characteristics of the Diode ($T_c=25^{\circ}\text{C}$ unless otherwise specified)

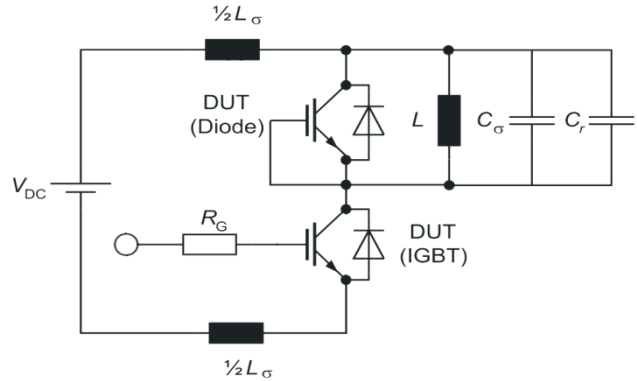
Symbol	Parameter	Conditions	Value			Units
			Min.	Typ.	Max.	
V_{FM}	Diode Forward Voltage	$I_F=40\text{A}$	--	2.2	3.0	V
T_{rr}	Reverse Recovery Time	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$	--	180	--	ns
I_{RRM}	Diode Peak Reverse Recovery Current		--	10	--	A
Q_{rr}	Reverse Recovery Charge		--	2.4	--	μC

Test Circuit

1) Gate Charge Test Circuit

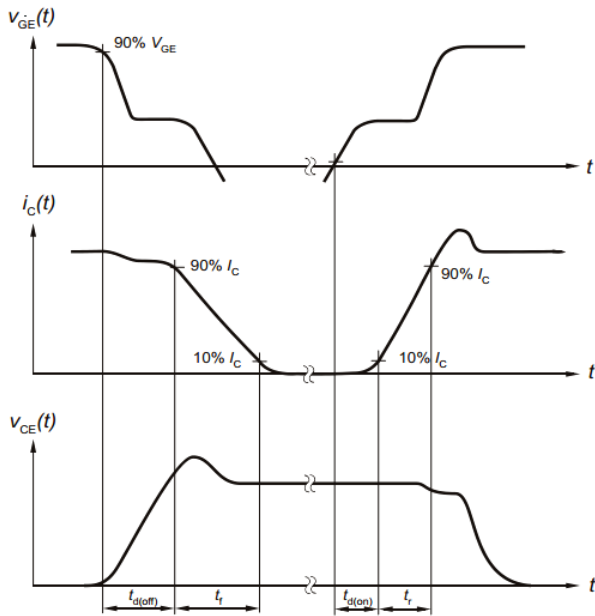


2) Switch Time Test Circuit

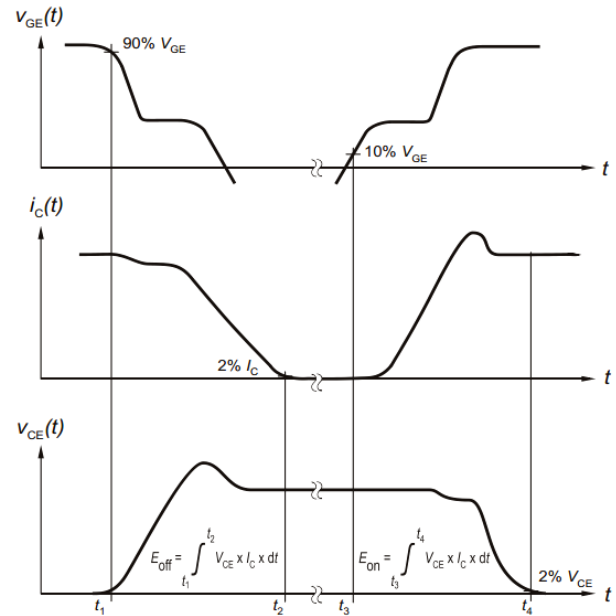


Switching characteristics

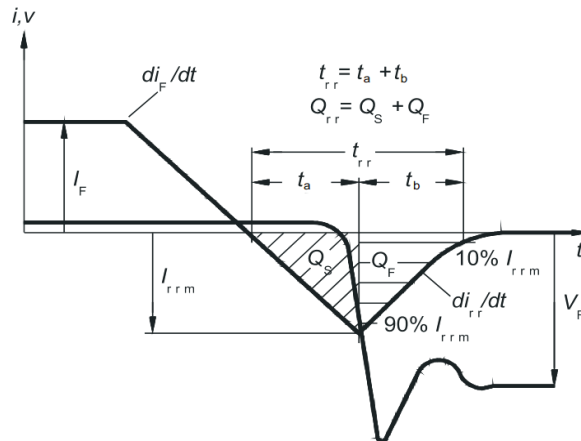
1) Definition of switching times



2) Definition of switching losses



3) Definition of diode switching characteristics



Typical Electrical and Thermal Characteristics

Figure 1 Output Characteristics

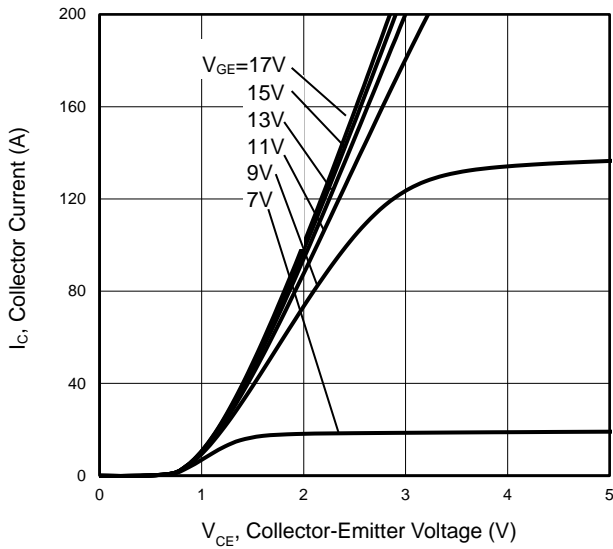


Figure 2 Transfer Characteristics

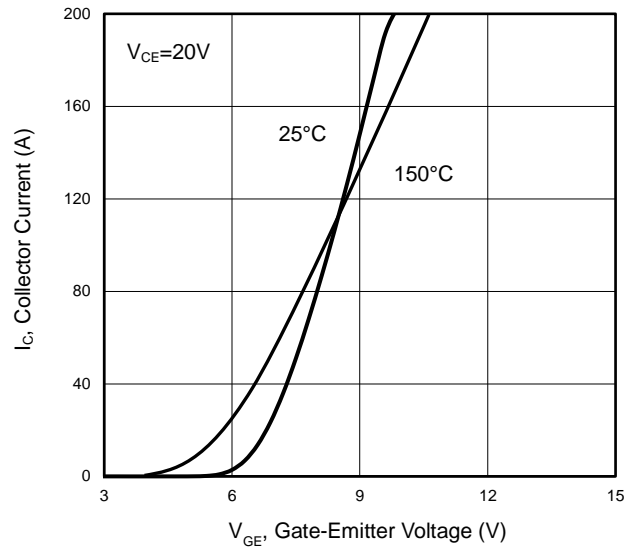


Figure 3 $V_{CE(sat)}$ vs. Case Temperature

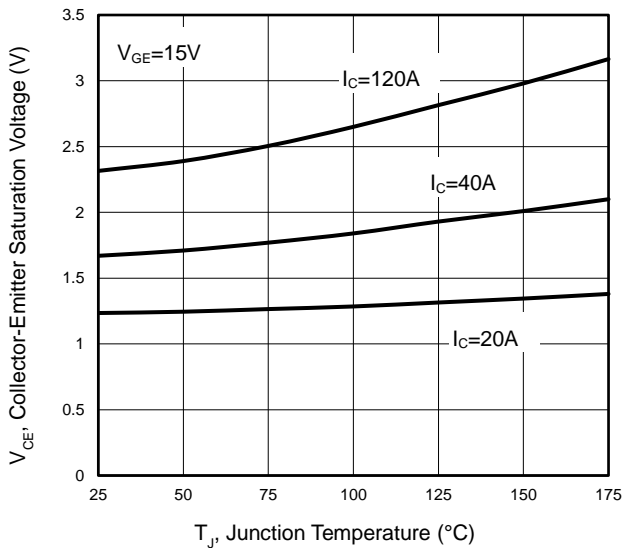


Figure 4 Saturation Voltage vs. V_{GE}

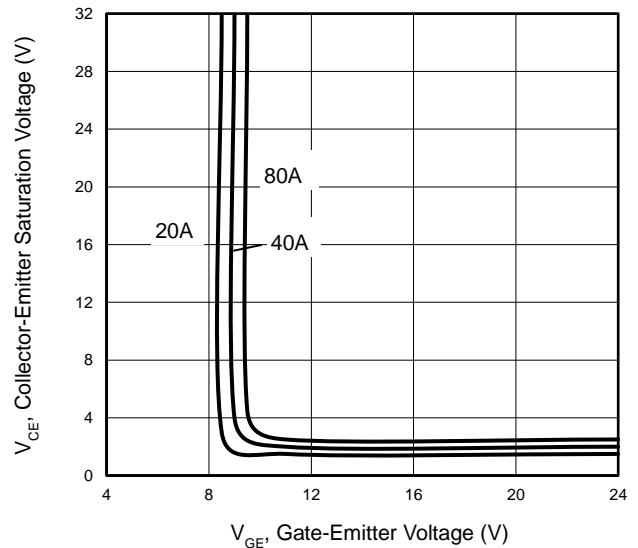


Figure 5 Capacitance Characteristics

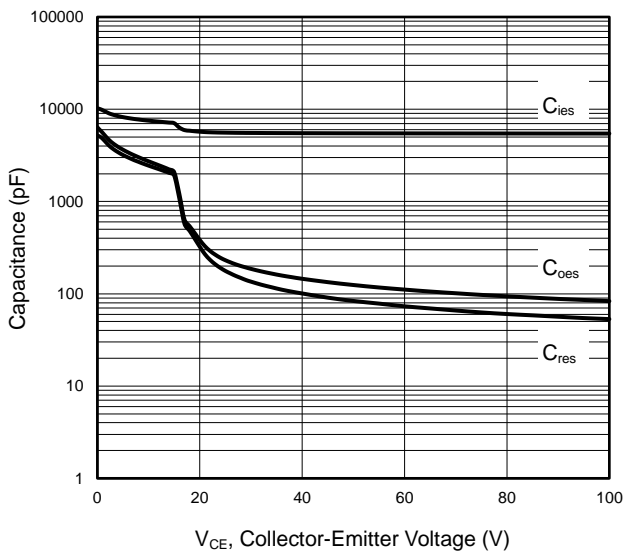
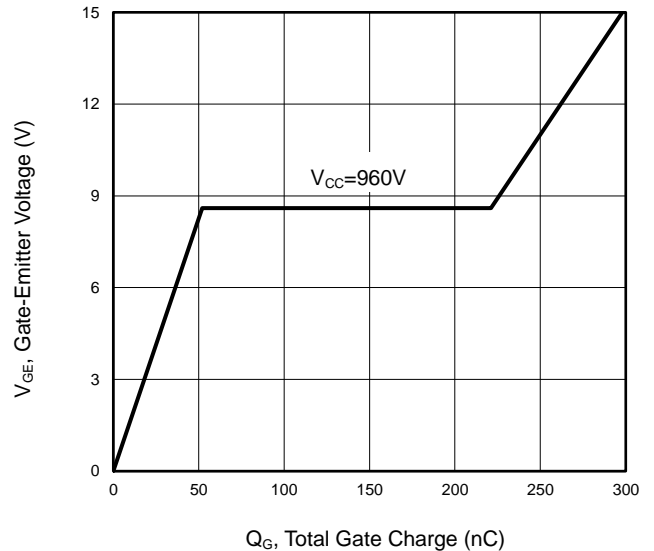


Figure 6 Gate Charge Wave Form



Typical Electrical and Thermal Characteristics

Figure 7 Forward Characteristics

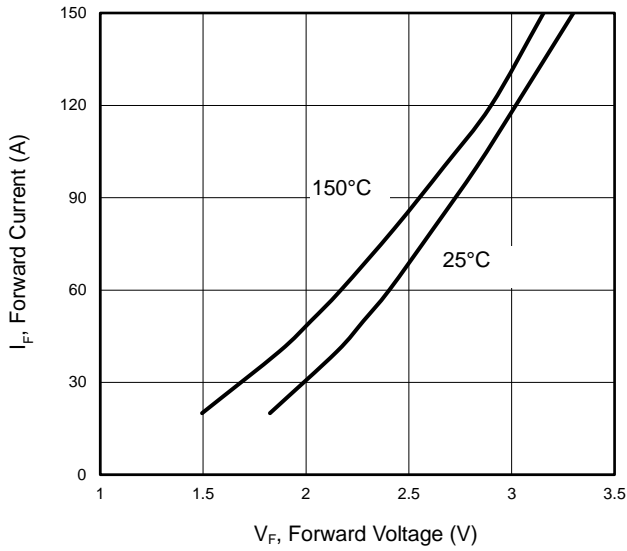


Figure 8 V_F vs. Temperature

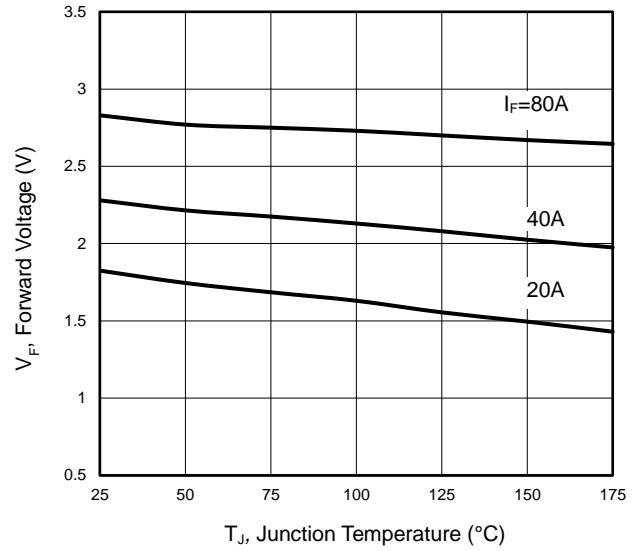


Figure 9 Switching Energy vs. Temperature

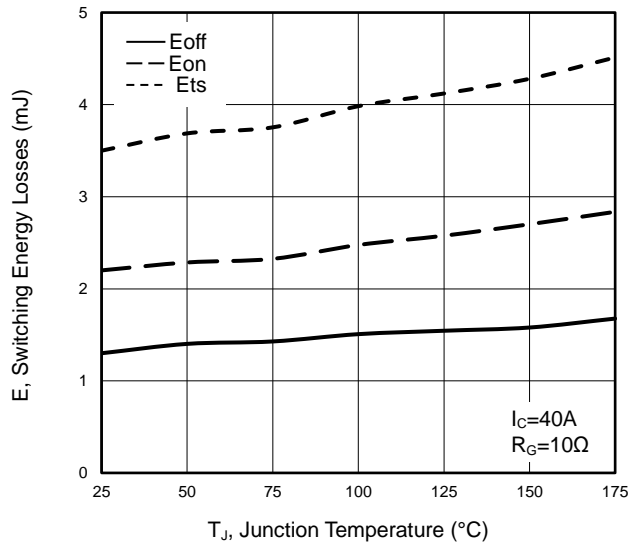


Figure 10 Forward Bias Safe Operating Area

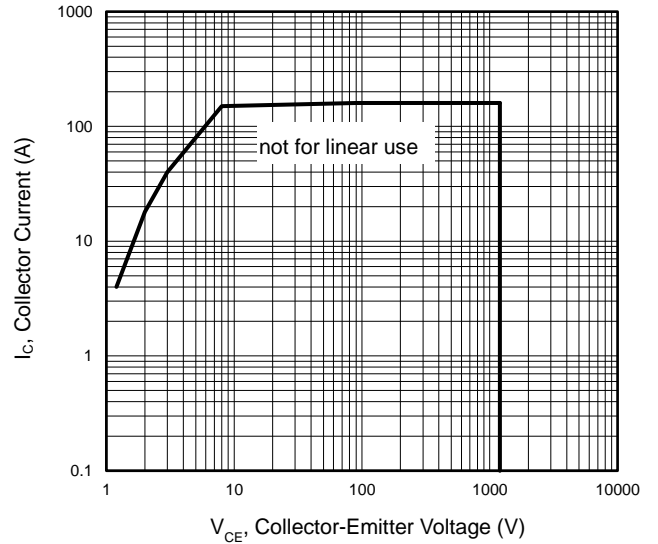


Figure 11 Gate-Emitter Threshold Voltage as a Function of Junction Temperature

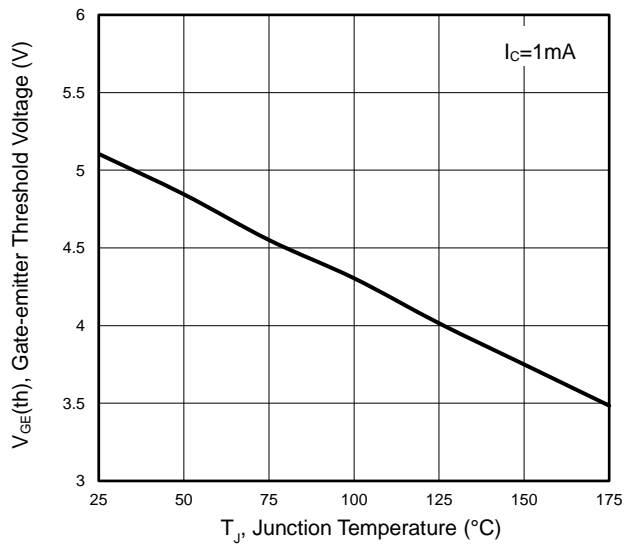
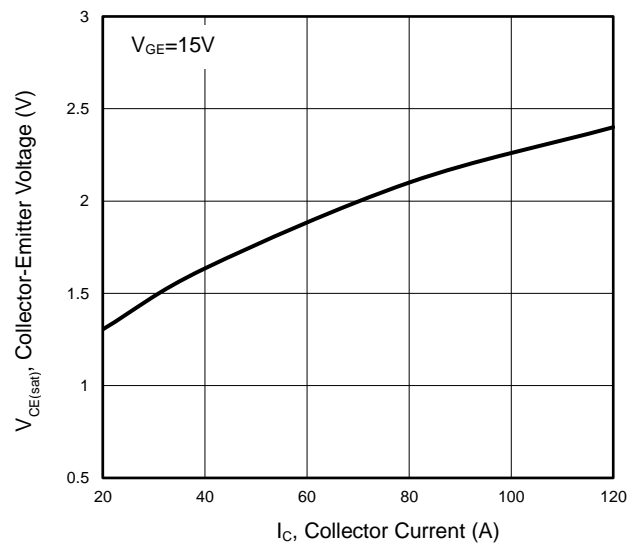


Figure 12 Typical Collector-Emitter Saturation Voltage as a function of Collector Current



Typical Electrical and Thermal Characteristics

Figure 13 Switching Loss vs. R_G

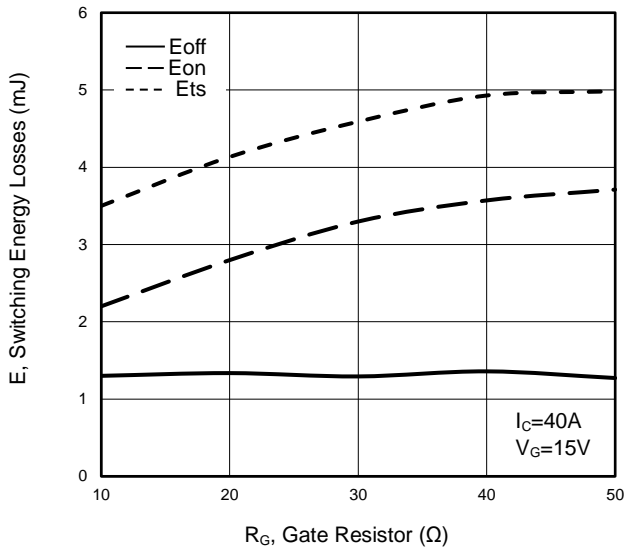


Figure 14 Switching Loss vs. Collector Current

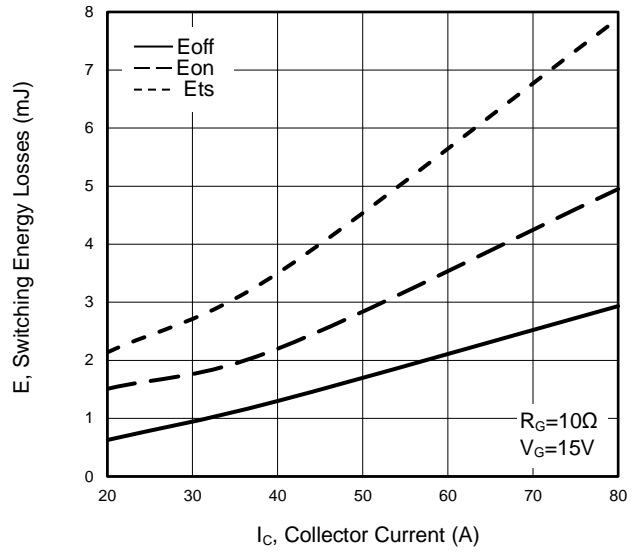


Figure 15 Switching Loss vs. Collector Current

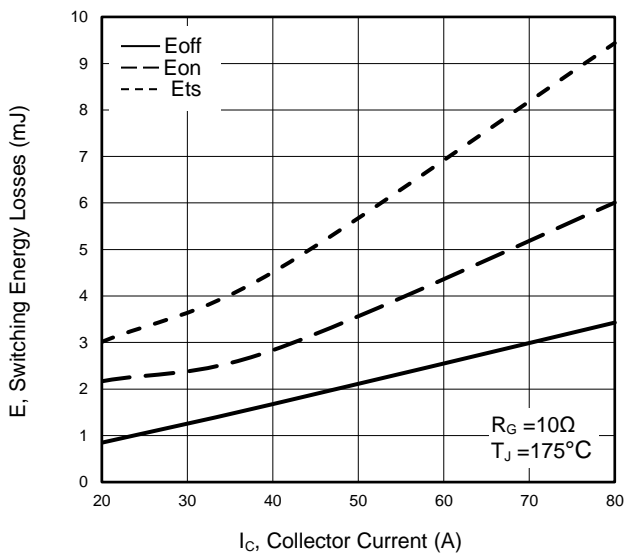


Figure 16 P_{tot} vs. Case Temperature

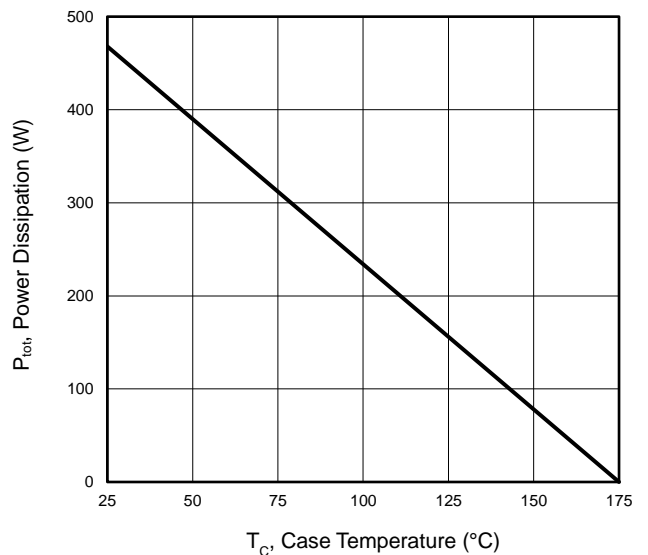


Figure 17 V_{CES} vs. Temperature

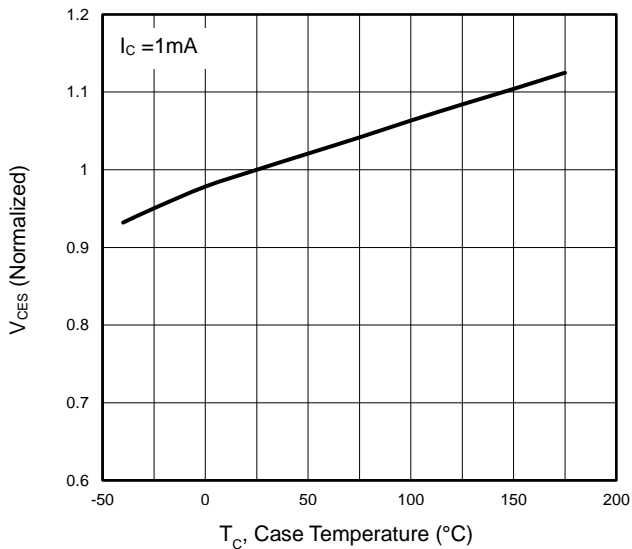
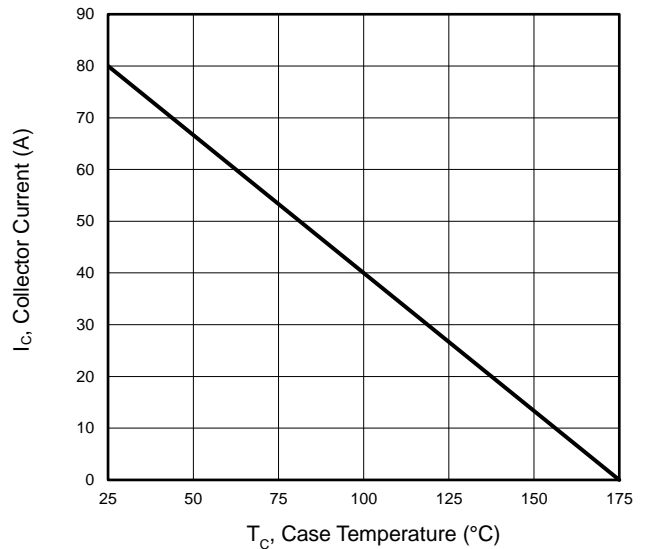


Figure 18 I_C vs. Temperature



Typical Electrical and Thermal Characteristics

Figure 19 Switching Time vs. I_C

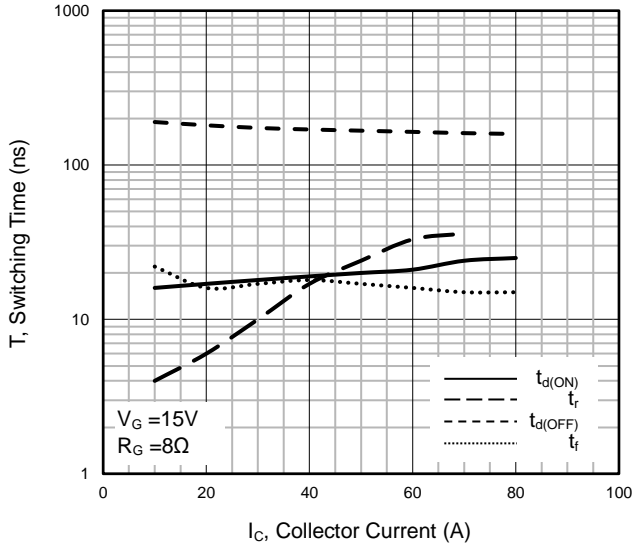


Figure 20 Switching Time vs. R_G

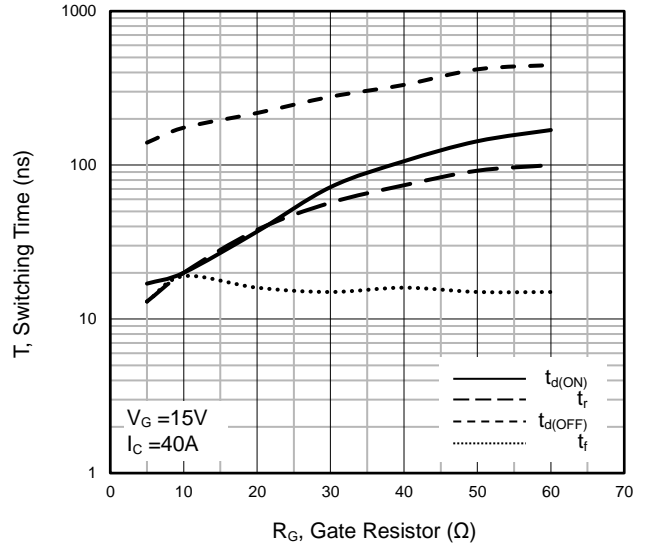


Figure 21 $V_{CE(sat)}$ vs. Collector Current

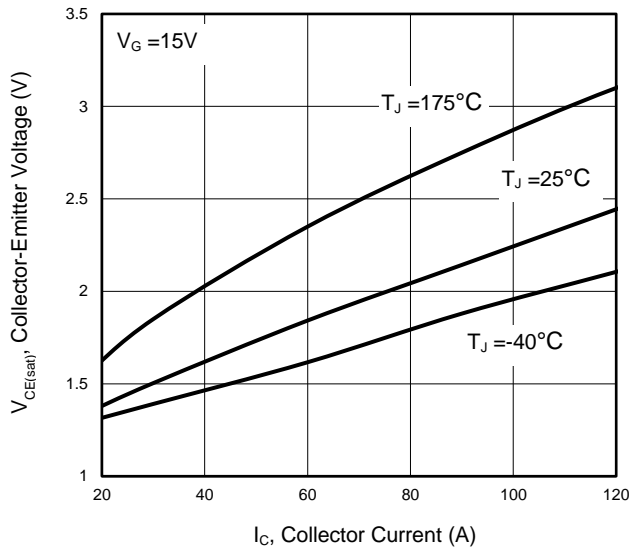


Figure 22 Switching Loss vs. V_{CE}

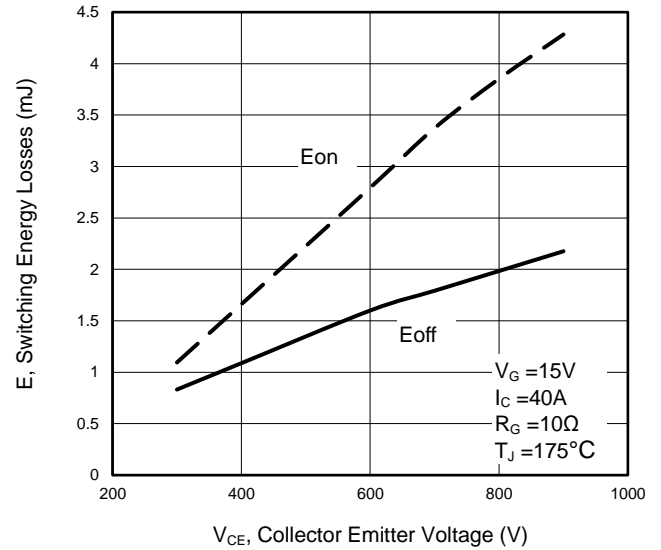


Figure 23 Switching Time vs. I_C

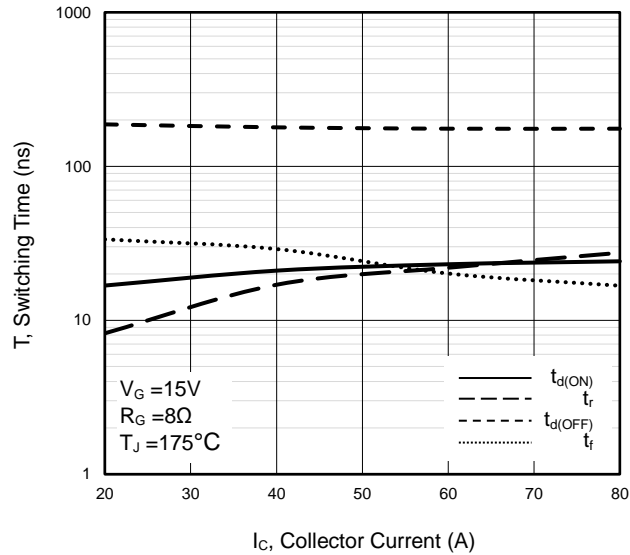
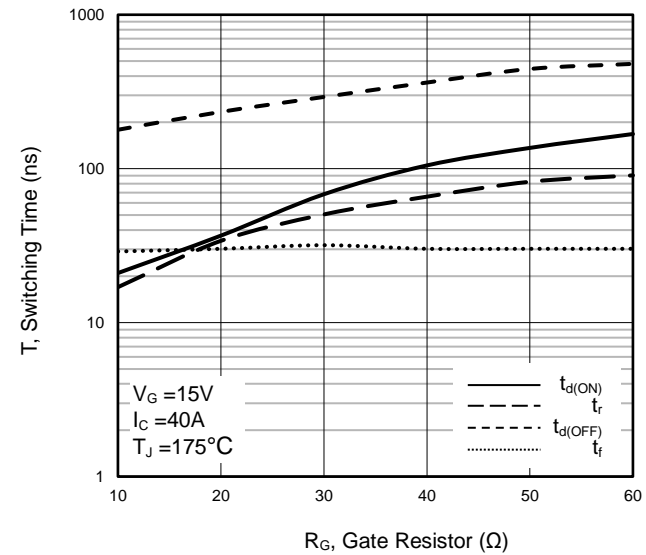
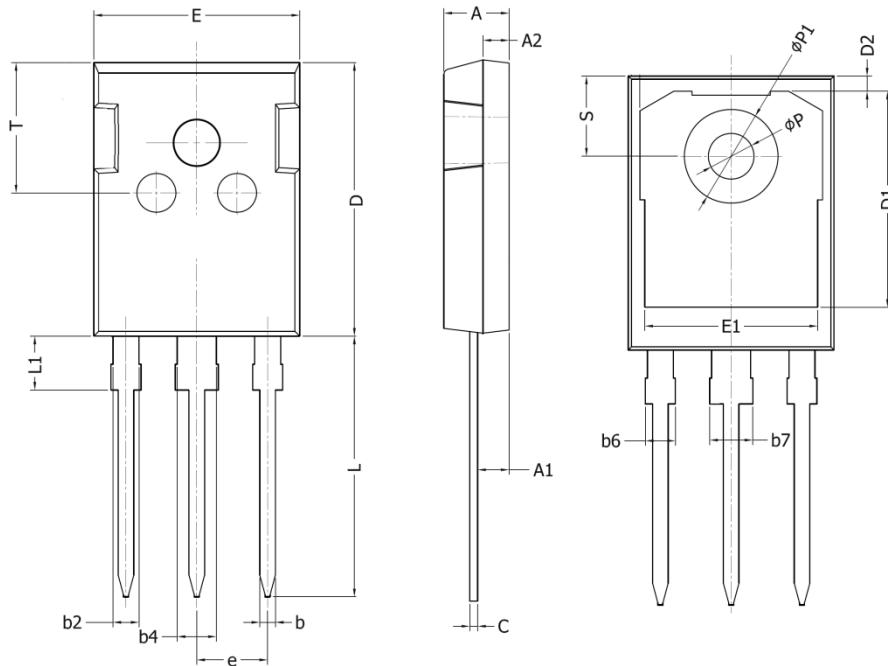


Figure 24 Switching Time vs. R_G

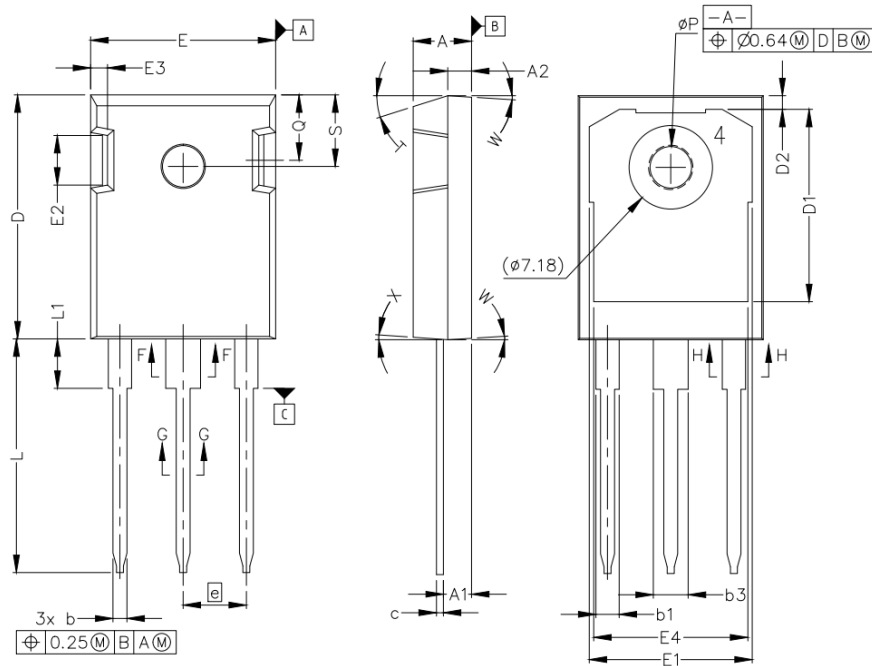


TO-247-P Package Information



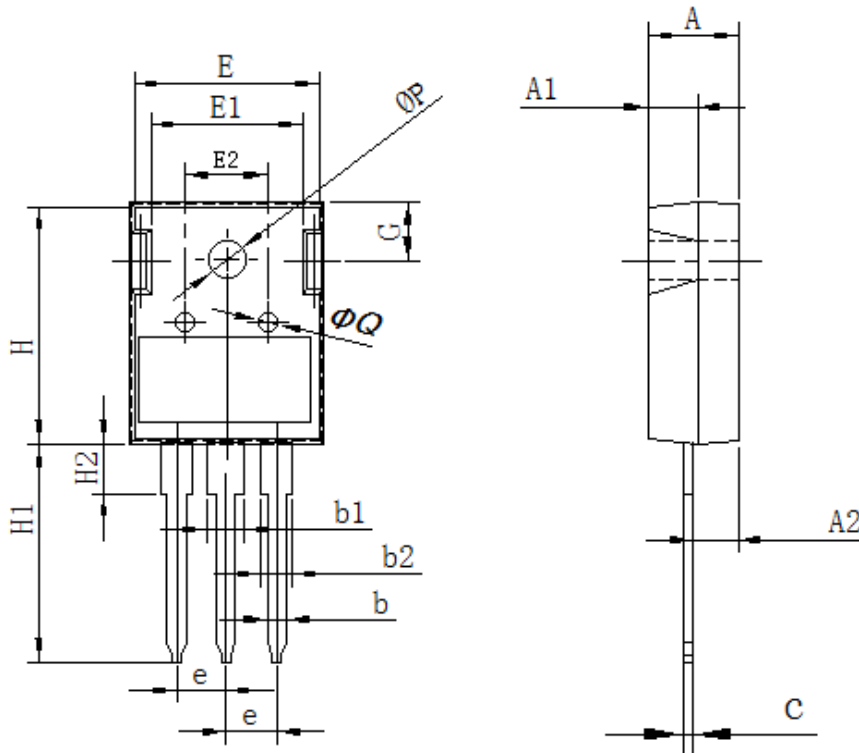
Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.90	5.10	0.193	0.201
A1	2.31	2.51	0.091	0.099
A2	1.90	2.10	0.075	0.083
b	1.16	1.26	0.046	0.050
b2	1.96	2.06	0.077	0.081
b4	2.96	3.06	0.117	0.120
b6	-	2.25	-	0.089
b7	-	3.25	-	0.128
C	0.59	0.66	0.023	0.026
D	20.90	21.10	0.823	0.831
D1	16.25	16.85	0.640	0.663
D2	1.05	1.35	0.041	0.053
E	15.70	15.90	0.618	0.626
E1	13.10	13.50	0.516	0.531
e	5.436 BSC		0.214 BSC	
L	19.80	20.10	0.780	0.791
L1	-	4.30	-	0.169
P	3.40	3.60	0.134	0.142
P1	7.00	7.40	0.276	0.291
S	6.05	6.25	0.238	0.246
T	9.80	10.20	0.386	0.402

TO-247-B Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.83	5.21	0.190	0.205
A1	2.29	2.54	0.090	0.100
A2	1.91	2.16	0.075	0.085
b	1.07	1.33	0.042	0.052
b1	1.91	2.41	0.075	0.095
b3	2.87	3.38	0.113	0.133
c	0.55	0.68	0.022	0.027
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.95	1.25	0.037	0.049
E	15.75	16.13	0.620	0.635
E1	13.10	14.15	0.516	0.557
E2	3.68	5.10	0.145	0.201
E3	1.00	1.90	0.039	0.075
E4	12.38	13.43	0.487	0.529
e	5.44 BSC		0.214 BSC	
N	3.00		0.118	
L	19.81	20.32	0.780	0.800
L1	4.10	4.40	0.161	0.173
P	3.51	3.65	0.138	0.144
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248

TO-247-d Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.80	5.20	0.189	0.205
A1	2.80	3.20	0.110	0.126
A2	2.20	2.60	0.087	0.102
b	1.05	1.35	0.041	0.053
b1	2.80	3.20	0.110	0.126
b2	1.80	2.20	0.071	0.087
c	0.50	0.70	0.020	0.028
e	5.25	5.65	0.207	0.222
E	15.60	16.00	0.614	0.630
E1	12.30	12.70	0.484	0.500
E2	6.00	6.40	0.236	0.252
H	20.50	21.50	0.807	0.846
H1	19.00	21.00	0.748	0.827
H2	3.00	5.00	0.118	0.197
G	5.70	6.10	0.224	0.240
ΦP	3.30	3.50	0.130	0.138
ΦQ	2.30	2.70	0.091	0.106

Attention

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